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On the Study of Reconfigurable Intelligent Surfaces in the Near-Field Region

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Abstract— As a reconfigurable intelligent surface (RIS) is expected to be implemented with a large aperture in terms of wavelengths, using a RIS to perform near-field rather than conventional far-field communications might gain some benefits. The electric fields in the near-field region from the near-field focusing and conventional far-field RISs are simulated and compared to assess and validate the benefits. Two metrics of benefit distance and near-field gain are defined to characterize the electric fields in the near-field region. The cumulative distribution function (CDF) related to the near-field gain is calculated to describe the benefits in the area of interest where the total scan patterns from the near-field focusing and conventional far-field RISs are plotted. For demonstration, the benefit distance, near-field gain, and CDFs are presented and calculated for near-field focusing RISs with assigned focal distances of 80 and 300mm. It is concluded that the benefit distance is a critical factor affecting the CDF directly. The effects of the size of a RIS and phase quantization of elements on the benefit distance, near-field gain, and CDF are also discussed. Moreover, the maximum focal distance of a near-field focusing RIS with a certain size is derived and specified. Finally, the electric fields of three prototypes (e.g., conventional far-field RIS, near-field focusing RISs with assigned focal distances of 500 and 1500mm.) at 26GHz are measured and compared, where the benefit distances and near-field gains are experimentally observed.

Index Terms— Reconfigurable intelligent surfaces (RISs), near-field focusing, electric fields, cumulative distribution function.

I. INTRODUCTION

Reconfigurable intelligent surfaces (RISs) are emerging communication paradigms, drawing lots of attention as they are promising solutions for the evolved 5G and upcoming 6G wireless communications [1]-[4]. RISs are kinds of surfaces that are composed of lots of artificial elements, where the reflection phase on each element can be controlled by switching electronic components, e.g., PIN diodes or RF switches [5]-[9]. As a result, RISs can direct the propagation of wireless signals, and suppress interference at desired receivers significantly, as well as enhance security with respect to non-intended receivers, by manipulating the radiation beams of the RIS intelligently.

Recently, investigations and discussions of RISs on the

reliabilities, possibilities, and advantages have been widely done [10]-[17], which has theoretically and experimentally verified that RISs can greatly improve the spectral efficiency and channel capacity. In [15], comprehensive discussions on the differences, similarities, and performance comparisons between the RIS and relay node were carried out, concluding that the sufficiently large RISs can outperform relay-aided systems in terms of data rate while reducing the energy consumption and implementation complexity.

So far, most of the research work related to the RISs is mainly focused on studies, implications, and characterizations on practical RIS implementations following the far-field assumptions for far-field application scenarios. As a RIS is expected to be implemented with a large aperture in terms of wavelengths in the frequency range of interest, users or receivers might be distributed in the near-field region of a RIS (in some indoor application scenarios for example) as mentioned in [12]. In this case, the near-field assumptions should be adopted to analyze the performance of a RIS. There is, however, very little literature to systematically evaluate the electric-field activities in the near-field region of a RIS. Very recently, the near-field behaviors of RISs were studied in [18] with a simplified RIS model, where the mutual couplings among elements were not considered and the radiation pattern of each element was modeled as isotropic. Nevertheless, some potential benefits could be observed and predicted by using a RIS to perform near-field instead of the conventional far-field communications in a wireless system. In near-field wireless communications, the near-field focusing capable of achieving focal spots with high energy in the near-field region serves as one of the critical technologies. The properties of the focal spot of a near-field focusing surface can be controlled freely by manipulating the radiation phases of radiating elements.

In this paper, it is the first time, to the authors' best knowledge, to carry out a thorough study and comparison of the characteristics of a RIS in its near-field region. The electric field is selected as the evaluation target, where the electric fields in the near-field region from the near-field focusing and conventional far-field RISs are simulated and compared. A metric of benefit distance is defined to quantify the spatial distance that the near-field focusing RIS can outperform the conventional far-field RIS in terms of electric-field amplitudes. Another metric of near-field gain is defined as the difference of the electric fields from the near-field focusing and conventional far-field RISs at the same positions. Besides, the phase quantization of elements building a RIS and the size of a RIS are also studied to check their impacts on benefit distance and near-field gain. Further, the maximum actual focal distance of a

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certain-size RIS is also investigated. These studies offer profound and instructive guidelines for the designs of the near-field focusing RISs in practical applications. Three prototypes with distinct focusing properties have been fabricated, the electric fields along the boresight direction are measured to demonstrate the benefit distances and near-field gains.

The remainder of the paper is organized as follows: Section II states the near-field application scenario of a RIS. The performance of a RIS in its near-field region is characterized in Section III, some metrics are defined to assess the benefits gained from a near-field focusing RIS. Also, phase quantization of elements and the size of a RIS are studied in this Section to examine their effects on the performance of a near-field focusing RIS. Three prototypes have been fabricated and measured in Section IV. Some conclusions are finally drawn in Section V.

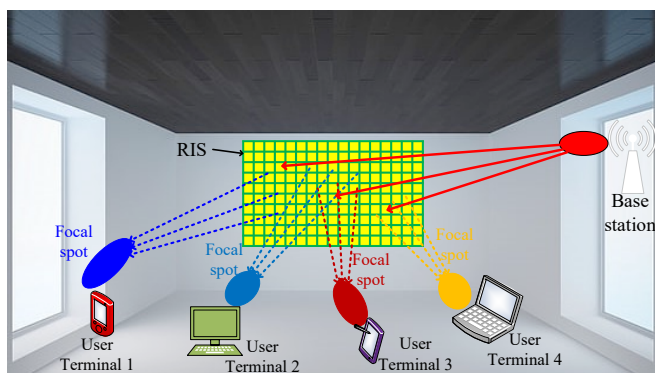


Fig. 1. The diagram of an application scenario of a near-field focusing RIS.

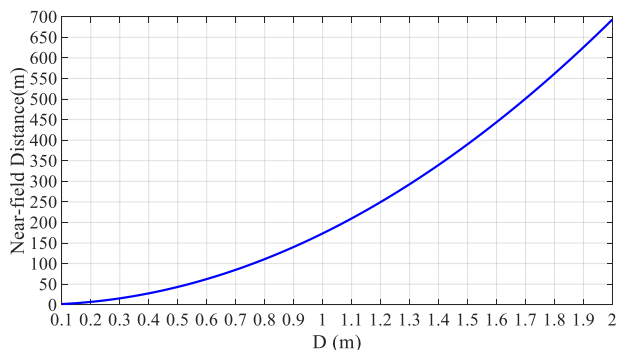


Fig. 2. The calculated near-field distance with different aperture sizes at 26GHz using Eq. (1). (D is the diagonal length of the square-shaped aperture)

II. APPLICATION SCENARIO STATEMENT

To illustrate the potential use case when user terminals (e.g., mobile phone, laptop, iPad, etc.) are located at the near-field region of a RIS, an application scenario is shown in Fig. 1. The RIS will receive the electromagnetic waves firstly from the base stations and then direct them to user terminals by manipulating the reflection phase of the RIS intelligently. The electromagnetic characteristics emanating from an antenna, as is known to all, vary as a function of distance. As a result, the free space with respect to the antenna can be broadly divided

into two regions, e.g., the near-field and far-field regions.

For an antenna, its near-field region is evaluated by [19]:

$$d = \frac{2D^2}{\lambda} \quad (1)$$

where D is the minimal diameter of a sphere that encloses the antenna, for an aperture antenna, D is the diagonal length of the aperture antenna with a rectangular/square shape, λ is the wavelength at the frequency of interest. Fig. 2 plots the near-field distance of a square-shaped RIS with different sizes at 26GHz using Eq. (1). It is observed, for example, that the near-field distance of a RIS with a size of 500mm \times 500mm is around 86.6m. The near-field distance will be huge (several hundred meters) when the size of a RIS reaches the order of a few square meters, which can generally cover all space of an indoor scenario. As a result, it inspires one to consider using a RIS to perform near-field rather than conventional far-field communications in wireless systems. As the sizes of the receivers (e.g., user terminal) are much smaller than a RIS, the RIS is usually located at the far-field region of the receivers, indicating that the RIS will not affect the performance (e.g., radiation pattern, input impedance, etc.) of the receivers. On the other hand, the receivers do not disturb the field distributions in the near-field region due to the small sizes despite they are always located at the near-field region of the RIS.

III. PERFORMANCE ANALYSIS OF A RIS IN ITS NEAR-FIELD REGION

In this section, the performance of the near-field focusing RIS in the near-field region is studied and compared to that of the conventional far-field RIS to demonstrate the benefits that the near-field focusing RIS can gain. All the RISs presented in this Section are the same type (dielectric-based RISs) and designed based on the same method. To follow and understand the work easily, this Section has been divided into four parts. In subsection *A*, a 200mm \times 200mm RIS is established with dielectric-based elements capable of continuous reflection phase shifts (e.g., $0 \sim 2\pi$), and its electric fields are simulated and then compared with the conventional far-field RIS in the near-field region when the assigned focal distances locate at different locations. Two metrics of benefit distance and near-field gain are defined, and the cumulative distribution function (CDF) are calculated to assess the benefits that the near-field focusing RIS can gain. In subsections *B* and *C*, the effects of the phase quantization (e.g., 1- and 2-bit) of elements building the RIS and the size of the RIS on the benefit distance, near-field gain, and cumulative distribution function have been examined. In subsection *D*, the maximum actual focal distance of a certain-size RIS is also studied. The results obtained in subsections *B*, *C*, and *D* provide some general guidelines for the design of the near-field focusing RISs in practical applications.

A. Simulation setup and basic metric definitions.

For a conventional far-field RIS, the radiation beam of the RIS is typically characterized by a solid angle (θ , φ) in the

spherical coordinate. By contrast, the location of the focal spot of a near-field focusing RIS is positioned with (r, θ, φ) in the spherical coordinate, indicating that we have one more degree of freedom to control the focal spot.

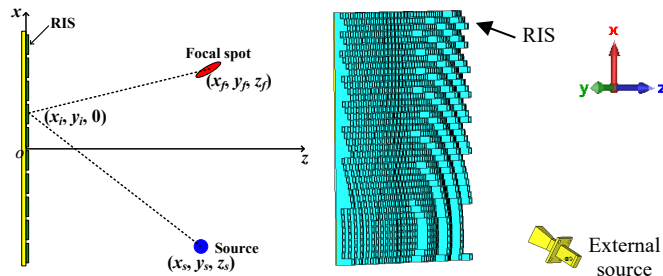


Fig. 3. (a). A simple diagram of a RIS illuminated with an external source to achieve a focal spot in the near-field region. (b). An example of the simulation model in CST software.

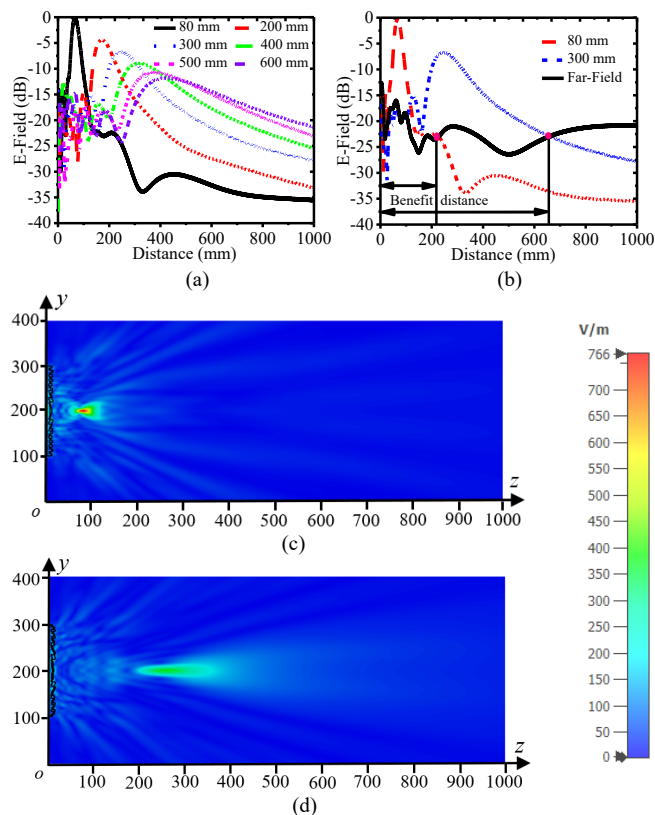


Fig. 4. Near-field focusing performance of a RIS. (a). The electric field along the boresight direction with the assigned focal distances of 80, 200, 300, 400, 500, 600mm. (b). The electric field along the boresight direction with the assigned focal distance of 80 and 300mm, and the referred far-field. (c). The electric-field distribution on the yo z -plane with the assigned focal distance of 80mm. (d). The electric-field distribution on the yo z -plane with the assigned focal distance of 300mm. (The units for y - and z -axis are millimeters in both Figs. (c) and (d)).

Still, the manipulations of the focal spot of a near-field focusing RIS rely on controlling the reflection phase of each element of the RIS. Fig. 3(a) presents a simple diagram of a RIS illuminated with an external source, where the external source can offer either a spherical or plane wave. The RIS is usually composed of periodic elements with a periodicity of around

half-wavelength at the frequency of interest in free space. The RIS first receives the electromagnetic waves from the external source and then can achieve a focal spot in the near-field region. For a focal spot at a specific position of (x_f, y_f, z_f) , the phase on element i of the RIS is formulated as:

$$\varphi(x_i, y_i, 0) = -\frac{2\pi}{\lambda} \left(\sqrt{(x_s - x_i)^2 + (y_s - y_i)^2 + (z_s)^2} + \sqrt{(x_f - x_i)^2 + (y_f - y_i)^2 + (z_f)^2} \right) \quad (2)$$

where (x_s, y_s, z_s) is the location of the phase center of the external source, $(x_i, y_i, 0)$ is the location of the element i in the RIS, and λ is the wavelength at the frequency of interest.

To demonstrate the performance and properties of a near-field focusing RIS, we build a $200\text{mm} \times 200\text{mm}$ RIS by using dielectric-based reflective elements with a periodicity of 5mm for the sake of saving simulation time. The detailed information about the dimensions and frequency responses of the dielectric-based elements can be found in the Appendix. The reflection phase of the element can be controlled by tuning the height of the element. The RIS is obliquely illuminated with a linearly-polarized horn antenna that generates spherical waves. The horn antenna can offer a gain of 10 dBi at 26GHz. According to the radiation patterns of the horn antenna at 26GHz, the location of the phase center of the horn antenna is set as (95mm, 0, 106.5mm) to eliminate its blockage effects and offer a good aperture illumination. The illumination taper can also be found in the Appendix. Using Eq. (2), we can calculate the phase distributions of elements on the RIS at 26GHz with assigned focal distances of 80mm, 200mm, 300mm, 400mm, 500mm, 600mm along the boresight direction (z -direction). The near-field focusing performance of the RISs is simulated with CST Microwave Studio software. An example of a simulation model established in CST is depicted in Fig. 3(b). Fig. 4(a) presents the electric fields in the z -direction from 0 to 1000 mm (corresponding to 0 to 87λ). It is observed that the simulated actual focal distance (the location corresponding to the peak electric-field amplitude) is smaller than the assigned focal distance. The distance discrepancy between the locations of the actual and assigned focal spots is named focal shift, which is attributed to the field-spreading factor $1/R$ as explained in [20], [21]. The focal shift becomes increasingly remarkable and the focal spot is less concentrated with the increment of the assigned focal distance as seen in Fig. 4(a). Indeed, the electric-field distributions on the yo z -plane of the RISs with assigned focal distances of 80mm and 300mm are plotted and shown in Figs. 4(c) and (d), where it is observed that the shape of the focal spot becomes longer for a larger assigned focal distance.

To illustrate the benefits from a RIS performing the near-field focusing, the electric fields of the conventional far-field RIS (RIS acts as a conventional directional reflector) along the boresight direction are also simulated. As seen in Fig. 4(b), there is no focal spot for the conventional far-field RIS from 0 to 1000mm. The intersection points of the electric fields between the near-field focusing and conventional far-field RISs

can be observed from Fig. 4(b), where the longitude distance of the intersection point is defined as *benefit distance* here. Within the benefit distance, the electric fields from the near-field focusing RIS are stronger than the counterparts from the conventional far-field RIS as seen in Fig. 4(b). It should be mentioned here that the electric field from the near-field focusing RIS will not intersect with that from the conventional far-field RIS again beyond the benefit distance. Besides, the benefit distance is becoming larger with the increment of the focal distance as observed in Fig. 4(b).

To assess the benefits we can gain in the near-field region by using the near-field focusing RIS instead of the conventional far-field RIS. A cumulative distribution function (CDF) related to the electric-field enhancement is proposed and defined as:

$$F(x) = P((E_{focusing} - E_{ref}) \leq x) \quad (3)$$

where $E_{focusing}$ is the electric-field amplitude from the near-field focusing RIS at a specific location, and E_{ref} is the electric-field amplitude from the conventional far-field RIS at the same location. The difference between $E_{focusing}$ and E_{ref} in logarithmic scale is named *near-field gain* here (e.g., Near-field Gain = $E_{focusing} - E_{ref}$), which also stands the ratio $E_{focusing}/E_{ref}$ in the linear domain. When a near-field gain is positive, it means $E_{focusing}$ is stronger than E_{ref} . The CDF implies the probability of the near-field gain less than a certain value in the area of interest that can be a line, a plane, or a volume.

To effectively accommodate scenarios with mobile users, the RIS should also be able to steer its radiation beam or focal spot. By selecting the points with the highest powers from all scanning beams or focal spots within a 2- or 3-dimensional space, a total scan pattern can be formed in a plane or volume accordingly. For demonstration, we select an area of $400\text{mm} \times 400\text{mm}$ on the $yo\text{-}z$ -plane as the area of interest as shown in Fig. 5 to reduce the simulation time and eliminate the blockage effects of the external source (horn antenna). The total scan patterns from the near-field focusing and conventional far-field RISs are simulated and plotted, where the CDFs related to the near-field gain can be calculated then according to the total scan patterns.

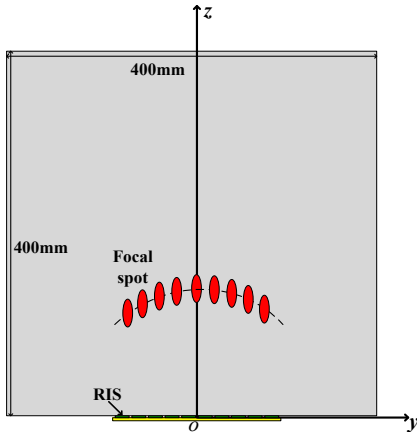


Fig. 5. The diagram of the scanning radiation beam/focal spot on the $yo\text{-}z$ -plane.

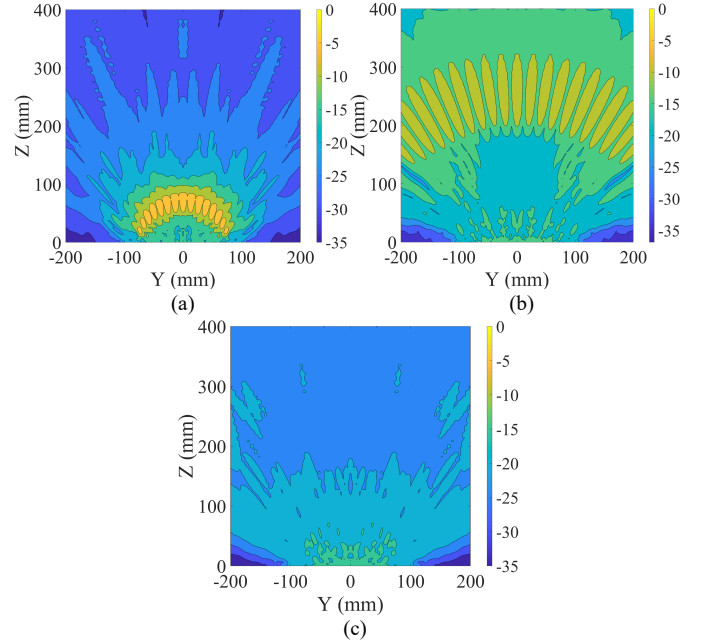


Fig. 6. The total scan patterns within the area of interest ($400\text{mm} \times 400\text{mm}$ on the $yo\text{-}z$ -plane) at 26GHz. (a). Near-field focusing RIS with an assigned focal distance of 80 mm. (b). Near-field focusing RIS with an assigned focal distance of 300mm. (c). Conventional far-field focusing RIS. (All values are normalized to the maximum electric-field amplitude of Fig. 6(a).)

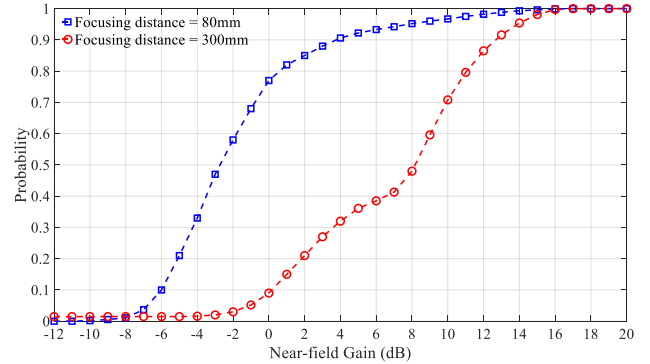


Fig. 7. The calculated CDFs of near-field gain of near-field focusing RISs with assigned focal distances of 80 and 300mm.

Here, we investigate and calculate the CDFs related to the near-field gain of the near-field focusing RISs. Figs. 6(a) and (b) plot the total scan patterns of the near-field focusing RIS with assigned focal distances of 80mm and 300mm in the area of interest, respectively. It is observed that the focal spots are scanned along the arcs with values equal to the assigned focal distances. The total scan pattern of the conventional far-field RIS at the same area of interest is also plotted in Fig. 6(c). As a result, the corresponding CDFs of the near-field focusing RISs with assigned focal distances of 80mm and 300mm are calculated and shown in Fig. 7.

Some information can be obtained from the calculated CDFs shown in Fig. 7. Note that the results in Fig. 7 have already included the conventional far-field RIS case as the near-field gain is defined as the difference between $E_{focusing}$ and E_{ref} . The maximum near-field gains are 15dB and 17dB for the near-field focusing RISs with assigned focal distances of 80mm and

300mm, respectively. On the other hand, the probability that the electric fields from a near-field focusing RIS stronger than the counterparts from the conventional far-field RIS in the area of interest with respect to a certain near-field gain value can be directly observed from the CDFs shown in Fig. 7. For the near-field focusing RIS with an assigned focal distance of 80mm, for example, the value of the corresponding CDF is 0.78 when the near-field gain is 0dB. The value of 0.78 implies the region that electric fields from the near-field focusing RIS are stronger than the counterparts of the conventional far-field RIS accounts for 22% of the area of interest ($400\text{mm} \times 400\text{mm}$). By contrast, the value of the CDF is only 0.09 when the near-field gain is 0dB for the near-field focusing RIS with an assigned focal distance of 300mm.

As seen in Fig. 7, the CDFs of the near-field focusing RISs with assigned focal distances of 80mm and 300mm are greatly distinct (the slopes of the curves are different). For example, the probabilities differ noticeably when the near-field gain is 0dB, they are 0.78 and 0.09. The differences of the CDFs can be explained from the 1-D electric fields shown in Fig. 4(b). Compared to the dimension of the area of interest ($400\text{mm} \times 400\text{mm}$ (yoz-plane)), the electric fields from the near-field focusing RIS with an assigned focal distance of 300mm are always stronger than those of the conventional far-field RIS within 400mm except for at some points close to the RIS as the benefit distance of the near-field focusing RIS is around 650mm. By contrast, as the benefit distance with an assigned focal distance of 80mm is only around 180mm, the electric fields of the near-field focusing RIS are only stronger than those of the conventional far-field RIS within 180mm. Beyond the benefit distance (from 180 to 400mm), the electric fields of the near-field focusing RIS are weaker than those of the conventional far-field RIS. As a result, it can be concluded that the benefit distance is a critical factor affecting the CDF.

It should be mentioned here, the CDF is also affected by the size of the area of interest. Specifically speaking, for a near-field focusing RIS with an assigned focal distance of 300mm, the CDFs will be different when the areas of interest are $400\text{mm} \times 400\text{mm}$ and $600\text{mm} \times 600\text{mm}$. The maximum near-field gains might be the same but the probabilities that the near-field gain is higher than an identical value will be distinct.

B. The effects of phase quantization on near-field focusing performance

The element enabled by liquid crystal technologies can offer continuous phase shifts by controlling the applied electric fields [22]-[24]. It, however, suffers from high loss and complicated manufacturing processes. By contrast, the 1-bit reflection phase has been widely adopted to enable beam-steerable reflectarray antennas by loading PIN diodes on each element [5]-[8]. The impacts of phase quantization on radiation patterns of a reconfigurable reflectarray antenna have been investigated and reported in [25]. It was concluded that the phase quantization would reduce the gain and increase the sidelobe level of a reflectarray antenna. Here, the effects of the phase quantization (1-bit, 2-bit, and continuous reflection phases) on the near-field focusing performance of a RIS are investigated.

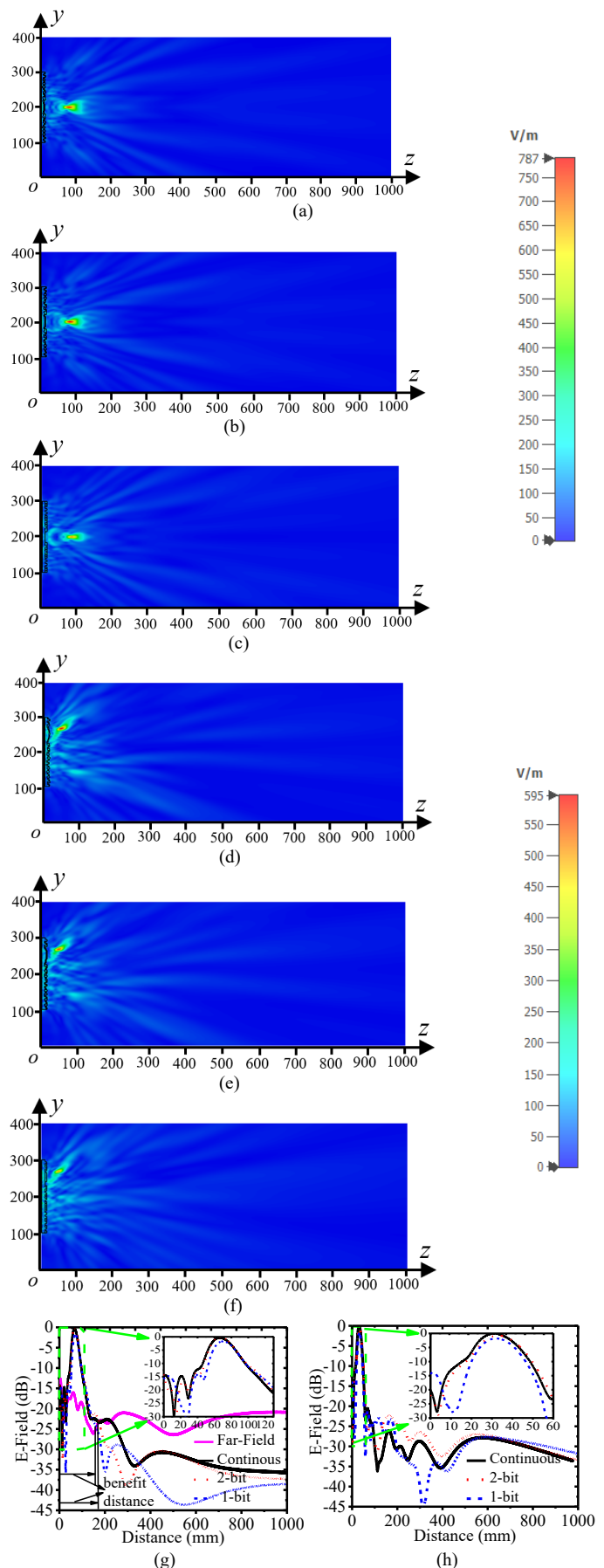


Fig. 8. The electric fields of a RIS with an assigned focal distance of 80mm

under different phase quantization. (a). Continuous with a focal spot at broadside direction. (b). 2-bit with a focal spot at broadside direction. (c). 1-bit with a focal spot at broadside direction. (d). Continuous with a focal spot at 60 degrees off-broadside direction. (e). 2-bit with a focal spot at 60degrees off-broadside direction. (f). 1-bit with a focal spot at 60degrees off-broadside direction. (g). Electric fields at the boresight direction with $y = 0\text{mm}$. (h). Electric fields at the boresight direction with $y = 68\text{mm}$. (The units for y - and z -axis are millimeters in both Figs. 8(a) - (f)).

For demonstration, a $200\text{mm} \times 200\text{mm}$ RIS is selected. The electric fields of the RIS are simulated and checked at both broadside and 60-degree off-broadside directions when the assigned focal distances are 80mm and 300mm, respectively. For the focal spot at broadside direction, the 2-D electric fields on the yz -plane for the RISs with assigned focal distances of 80mm and 300mm are shown in Figs. 8(a)-(c) and 9(a)-(c), respectively, when the elements offer continuous, 2-bit, and 1-bit reflection phases. Figs. 8(g) and 9(g) compare the 1-D electric fields along the boresight direction at $y = 0\text{mm}$, where the position and beamwidth of the focal spot can still be maintained with the three different phase quantization. However, the benefit distances and maximum electric-field amplitudes are shortened and reduced for the RIS with a 1-bit phase quantization, respectively. They are more remarkable when the focal distance is 300mm as can be observed in Fig. 9(g). According to the 2-D electric fields on the yz -plane for the assigned focal distances of 80mm and 300mm are plotted in Figs. 8(d)-(f), 9(d)-(f), and 1-D electric fields along the boresight direction at $y = 68\text{mm}$ and 212mm that the maximum electric-field amplitudes go through these lines as shown in Figs. 8(h) and 9(h), the peak electric-field amplitudes, positions, and the beamwidths of the focal spots are all quite stable and close to each other under the three different phase quantization when the focal spots are 60-degree off-broadside direction.

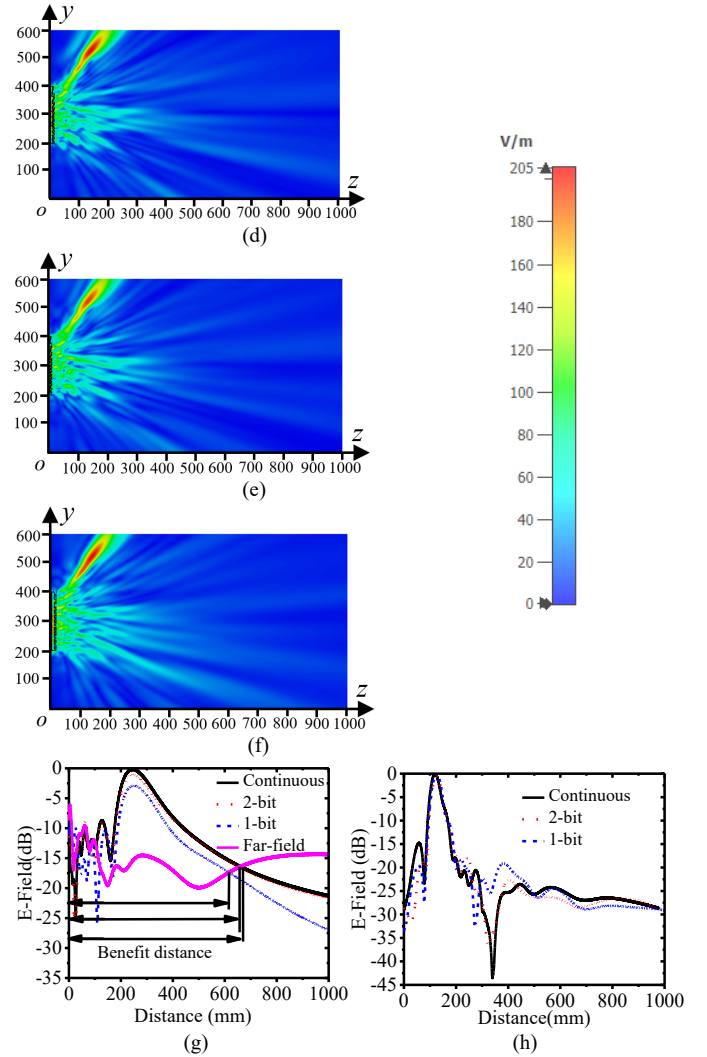
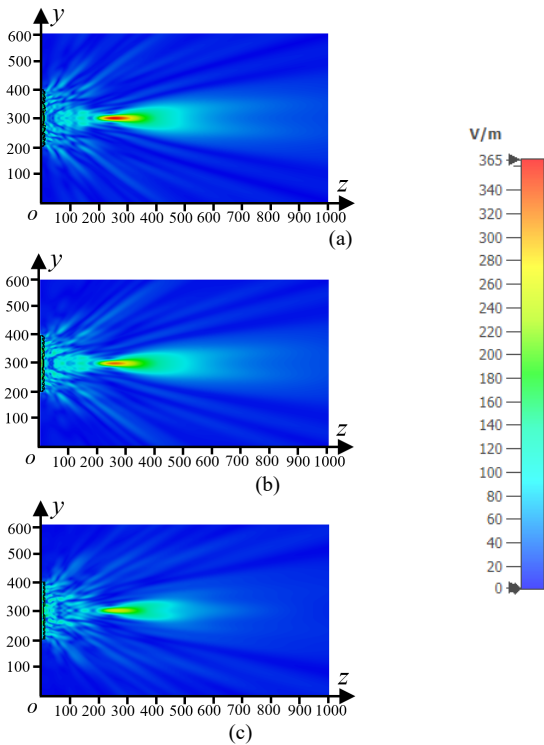


Fig. 9. The electric fields of a RIS with an assigned focal distance of 300mm under different phase quantization. (a). Continuous with a focal spot at broadside direction. (b). 2-bit with a focal spot at broadside direction. (c). 1-bit with a focal spot at broadside direction. (d). Continuous with a focal spot at 60 degrees off-broadside direction. (e). 2-bit with a focal spot at 60degrees off-broadside direction. (f). 1-bit with a focal spot at 60degrees off-broadside direction. (g). Electric fields at the boresight direction with $y = 0\text{mm}$. (h). Electric fields at the boresight direction with $y = 212\text{mm}$. (The units for y - and z -axis are millimeters in both Figs. 9(a) - (f)).

As can be observed in Figs. 8 and 9, the sidelobe levels of the RISs with continuous and 2-bit phase quantization are very close to each other, while they become worse for the RIS with a 1-bit phase quantization. The effects of phase quantization on the near-field focusing RISs are in line with the results in [29] in terms of sidelobe levels.

The total scan patterns of the RIS composed of 1-bit elements are also simulated in the area of interest ($400\text{mm} \times 400\text{mm}$) and plotted in Fig. 10 when the assigned focal distances are 80mm and 300mm, where the focal spots are still scanned along the arcs. According to the total scan patterns shown in Fig. 6(c) and Fig. 10, the CDFs related to the near-field gain of the near-field focusing RIS composed of 1-bit elements are calculated and plotted as shown in Fig. 11 when the assigned focal distances are 80mm and 300mm. The CDFs of the corresponding near-

field focusing RISs composed of elements with continuous reflection phases are also plotted in Fig. 11 for comparison. As seen in Fig. 11(a), it is observed that the maximum near-field gains are very close to each other for the RIS with continuous and 1-bit phase quantization when the focal distance is 80mm. As the benefit distance of the RIS composed of 1-bit elements is slightly smaller as seen in Fig. 8(g), the probability of the RIS composed of 1-bit elements is slightly higher than that of the RIS composed of the elements with continuous phases when the near-field gain is equal to 0dB, where the probabilities are 0.81 and 0.78, respectively.

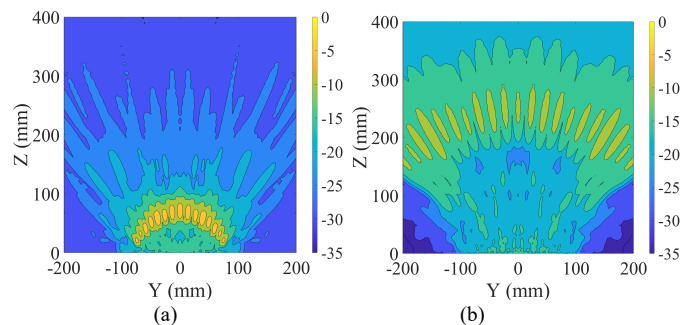


Fig. 10. The total scan patterns within an area of $400\text{mm} \times 400\text{mm}$ on the yo z-plane at 26GHz. (a). 1-bit near-field focusing RIS with an assigned focal distance of 80mm. (b). 1-bit near-field focusing RIS with an assigned focal distance of 300mm. (All values are all normalized to the maximum electric-field amplitude of Fig. 6(a).)

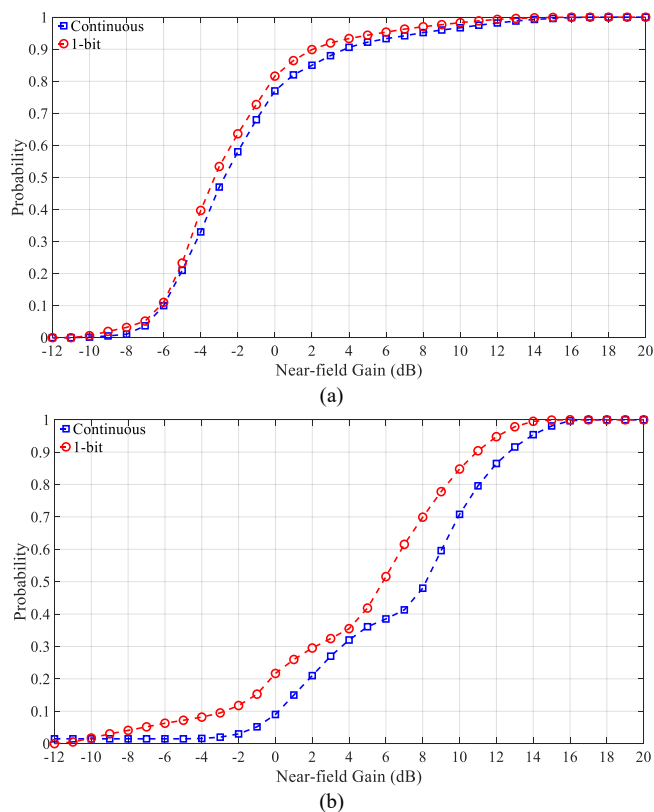


Fig. 11. The calculated CDFs. (a) Continuous and 1-bit near-field focusing RISs with an assigned focal distance of 80mm. (b) Continuous and 1-bit near-field focusing RISs with an assigned focal distance of 300mm.

By contrast, when the assigned focal distance is 300mm, the maximum near-field gains of the RISs composed of elements with continuous and 1-bit reflection phases are 17dB and 15dB, respectively, as observed in Fig. 11(b). As the benefit distance of the RIS composed of elements with 1-bit phase quantization is remarkably smaller as shown in Fig. 9(g), the probability of the RIS composed of 1-bit elements is noticeably higher than that of the RIS composed of the elements with continuous phases when the near-field gain is equal to 0dB, where the probabilities are 0.21 and 0.09, respectively.

According to the results shown in Figs. 8, 9, and 11, the effects of the phase quantization on the performance of a near-field focusing RIS are dependent on the specific position of the focal spot (e.g., focal distance, broadside or off-broadside direction, etc.). In general, a 2-bit phase quantization can achieve comparable and similar results with the continuous reflection phase in terms of maximum electric-field amplitude, benefit distance, and sidelobe levels. By contrast, the maximum electric-field amplitude will be reduced for the RIS with a 1-bit phase quantization, resulting in lowering the maximum near-field gain. When the focal distance is large, the benefit distance will be noticeably shortened for the RIS with a 1-bit phase quantization, which leads to a higher probability in terms of the CDF in the area of interest when the near-field gain is equal to a certain value as demonstrated in Figs. 11.

C. The effects of the RIS's size on near-field focusing performance

No doubt that the aperture size of a RIS is one of the most important parameters for RISs designs, as it does not only lead to different beamforming gains but also affects how much power (electromagnetic waves) that a RIS can capture from free space. To examine the effects of the size of a near-field focusing RIS on benefit distance, near-field gain, and CDF, the electric fields of the near-field focusing and conventional far-field RISs with dimensions of $200\text{mm} \times 200\text{mm}$ and $300\text{mm} \times 300\text{mm}$ are simulated and compared. For a fair comparison, the external sources (horn antennas) to illuminate the $200\text{mm} \times 200\text{mm}$ and $300\text{mm} \times 300\text{mm}$ RISs are identical, and the relative positions of the horn antennas with respect to the RISs should be kept the same as shown in Fig. 12 so that the RISs can capture the same power from the horn antennas. In other words, the electric-field illumination tapers on the RISs are the same for the two cases.

For demonstration, we simulate the electric fields along the boresight direction from the near-field focusing RIS with an assigned focal distance of 300mm and the conventional far-field RIS as shown in Fig. 13, where the counterparts from the $200\text{mm} \times 200\text{mm}$ RIS are also plotted for comparison. As seen in Fig. 13, the focal shift of a large-size RIS still exists but **is weaker than that of a small-size RIS**. A large-size RIS can offer a bigger maximum electric-field amplitude at the actual focal distance, where a 2.5dB electric-field amplitude higher can be observed for the large-size RIS from Fig. 13. On the other hand, the large-size RIS receives the same power as the small-size RIS from the horn antennas, the received power will be uniformly distributed on the RIS after the conventional

far-field RIS converting the spherical wave from the horn antenna to a plane wave. As a result, the electric fields along the boresight direction (electric-field density) from the large-size conventional far-field RIS are noticeably smaller than those of the small-size conventional far-field RIS as demonstrated in Fig. 13. The smaller electric field will lead to the near-field gain of the large-size RIS greater than that of the small-size RIS. The near-field gain at the actual focal distance is 27.5dB for the large-size RIS, while it is 16.0dB for the small-size RIS when the RISs have the same assigned focal distances of 300mm.

As the maximum electric-field amplitude from the large-size RIS is higher than that of the small-size RIS, the corresponding beamwidth of the focal spot is narrower, leading to a smaller benefit distance as can be observed in Fig. 13. The smaller benefit distance will affect the CDF in the area of interest (e.g., 400mm × 400mm) accordingly following the results shown in Fig. 11, where the maximum near-field gain is higher and the probability is smaller with respect to a certain near-field gain in the same area of interest.

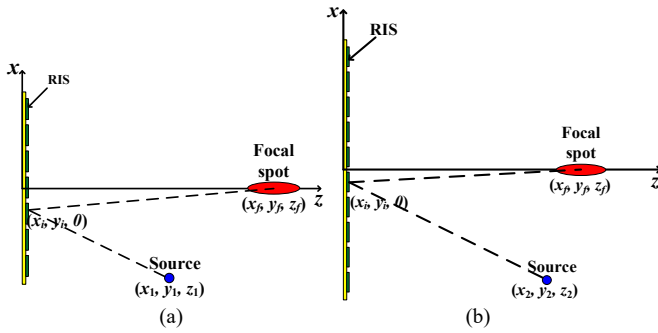


Fig. 12. Configurations of the RISs with different sizes. (a). 200mm × 200mm. (b). 300mm × 300mm.

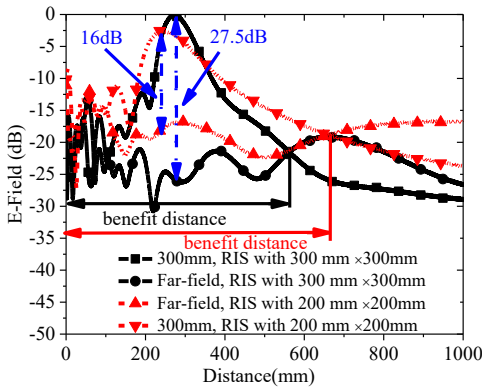


Fig. 13. The electric fields along the boresight direction for the RISs with dimensions of 200mm × 200mm and 300mm × 300mm.

D. The maximum focal distance of a RIS with a certain size.

Though the results so far suggest that performing near-field **focusing** can indeed enhance the field amplitude in the desired area greatly, the near-field gains of a given RIS size decay with an increased focusing distance as mentioned previously. According to the electric-field distributions under different assigned focal distances shown in Fig. 4(a), there should be a maximum actual focal distance for a certain-size RIS.

A general case is considered here to study the maximum

actual focal distance of a RIS, where the RIS is implemented with half-wavelength elements and illuminated with a normal plane wave. The corresponding actual focal distances are simulated for RISs with different sizes when the assigned focal distances vary as shown in Fig. 14, where R_0 and r_0 represent the actual and assigned focal distances, respectively. As seen in Fig. 14, all the actual focal distances converge to their respective maximum values for different size RISs when assigned focal distances reach beyond certain values. It is also found that the maximum values are much less than the calculated near-field regions of RISs with different sizes using Eq. (1). Besides, it is observed that, from Fig. 14, for a fixed assigned focal distance, the effect of the focal shift is noticeably weakened as the size of the RIS increases, which is consistent with the results shown in Fig. 13.

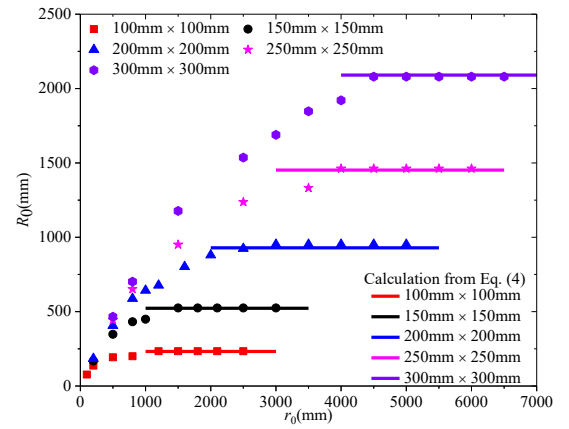


Fig. 14. The relationship between the assigned focal distance and the actual focal distance of different size RISs.

As can be seen in Fig. 14, the maximum actual focal distance is directly related to the size of the RIS, and it should also be associated with the frequency of interest. We need to find a proper formula to characterize the relationship among the maximum actual focal distance, the size, and operating frequency of a RIS. We know that the calculation of near-field region ($2D^2/\lambda$) involves the size of a RIS and the frequency of interest. Therefore, we are trying to normalize the maximum actual focal distance to $2D^2/\lambda$. After doing some calculations, the ratios of the maximum actual focal distances of different size RISs to their respective $2D^2/\lambda$ are almost the same, which can be broadly formulated as follows:

$$\frac{R_{0\max}}{2D^2/\lambda} \approx 0.067 \quad (4)$$

where $R_{0\max}$ is the maximum actual focal distance of a RIS. The maximum actual distances of RISs with different sizes are calculated with Eq. (4) and also plotted in Fig. 14, where the results from Eq. (4) align well with the simulations.

Eq. (4), on one hand, indicates that the maximum actual focal distance of a RIS is only 0.067 times of its near-field region calculated with $2D^2/\lambda$. It, on the other hand, imposes a threshold on the maximum actual focal distance that a RIS can

reach, which can be served as guidelines in practical designs of RISs.

IV. EXPERIMENTAL MEASUREMENT

From the above analyses, it is concluded that the benefit distance is a critical metric affecting the CDF directly. Besides, the results presented in Section III are obtained by studying the RISs implemented with dielectric-based reflective elements for the sake of saving simulation time. The RIS typically consists of thin PCB-based elements in practical RIS implementations [6]-[8]. Nevertheless, the conclusions derived in Section III are also applicable to the RISs composed of PCB-based elements. To this end, the experimental measurements are carried out on the PCB-based RISs. It will be a huge workload to measure the total scan patterns of the near-field and the conventional far-field RISs in the area of interest. As a result, the one-dimensional electric fields are measured to demonstrate the benefit distance and near-field gain.

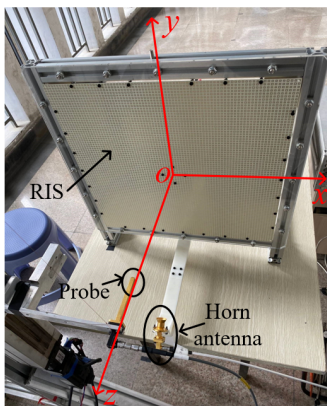


Fig. 15. Measurement setup.

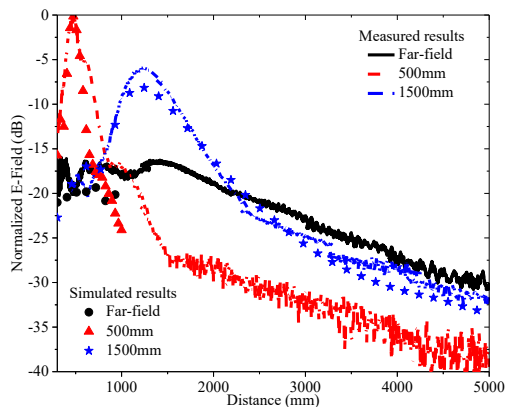


Fig. 16. The measured electric fields along the boresight direction from 300 to 5000mm from the three prototypes. (Far-field, near-field focusing with assigned focal distances of 500mm and 1500mm)

To reduce the measurement complexity and cost, we have fabricated three prototypes with each dimension of $400\text{mm} \times 400\text{mm}$ (e.g., conventional far-field RIS, near-field focusing RISs with assigned focal distances of 500mm and 1500mm). The elements building the prototypes are single-layered and double square-loop structures [26]. The substrates used in the

prototypes are all Rogers RO4350B with a thickness of 1.524mm, a dielectric constant of 3.55, and a loss tangent of 0.004 [27]. The electric fields of the three prototypes along the boresight direction from 300 to 5000mm have been measured and compared. The measurement setup is demonstrated in Fig. 15, where the origin of the coordinate is exactly located at the center of the prototype. The horn antenna serves as an external source to illuminate the RIS and the long open-ended waveguide acts as a probe to detect the fields.

Fig. 16 plots the electric fields of the three prototypes along the boresight direction (z -direction, $x = 0\text{mm}$, $y = 0\text{mm}$) from 300 to 5000mm (26λ to 433.3λ , λ is the wavelength at 26 GHz). Some discontinuities can be observed on curves in Fig. 16 as the scanner in the measurement setup can only automatically scan 1000mm each time, we have to move the measurement setup manually several times to finish the measurement from 300 to 5000mm. Since the dimensions of the fabricated prototypes are $400\text{mm} \times 400\text{mm}$, our available computer is not competent in fully simulating such large models with CST. As a result, some discrete simulated results are provided in Fig. 16 for comparison with the measurements. As seen in Fig. 16, the measured focal distances agree well with the simulations, while the measured electric-field amplitudes at the actual focal distances are smaller than those of the simulated results. There are two possibilities to result in the discrepancies: One is that the probe does not align with the center of the prototype during the measurement; the other is the deviation of the focal spot that the focal spot is not exactly located at the boresight direction (z -direction, $x = 0\text{mm}$, $y = 0\text{mm}$) for the prototypes. The deviation of the focal spot is caused by the assembly error that the relative position of the horn antenna with respect to the prototype is not the same as the simulation. From the measured results in Fig. 16, the benefit distances and near-field gains can be observed, which are all consistent with the results described in Section III.

V. CONCLUSION

The near-field behaviors of a near-field focusing RIS are thoroughly studied in this paper. By comparing the electric fields from the near-field focusing and conventional far-field RISs in the near-field region, it is found that the electric fields from the near-field focusing RIS are stronger than those from the conventional far-field RIS in some regions. To assess the benefits we can gain by using near-field focusing RIS, two metrics of benefit distance and near-field gain are defined, and cumulative distribution function (CDF) related to the electric-field enhancement are calculated.

By studying the near-field focusing RISs with assigned focal distances of 80mm and 300mm, it is concluded that a large focal distance contributes to a larger benefit distance and a smaller near-field gain, and the benefit distance affects the CDF directly. A large benefit distance usually results in a smaller probability in terms of CDF in the area of interest when the near-field gain is equal to a certain value. The effects of the phase quantization of elements building a RIS and the size of a RIS on benefit distance, near-field gain, and CDF are also studied. It is concluded that a 1-bit phase quantization shortens

the benefit distance and reduces the maximum near-field gain. Besides, a large-size RIS leads to a smaller benefit distance and enhanced near-field gain. The major conclusions observed from extensive simulation campaigns are verified through the electric fields along the boresight direction of the three prototypes, where the benefit distances and near-field gains are experimentally observed.

If the entire space of the room is within the near-field region of a RIS, using a RIS to perform near-field focusing indeed brings some benefits compared to the conventional far-field RIS in indoor wireless communication application scenarios. Moreover, we can assess the near-field gain according to the transmitted power from the base station to determine the size of the RIS accordingly if the deployment scenario and the desired power that users should receive are known.

APPENDIX

The dimensions of the dielectric-based element used in Section III are shown in Fig. A1. A cuboid air void is etched on the top of the dielectric stub to improve the relationship between the reflection phase and height of the dielectric stub (h). When the dimensions of a , p , and d are properly assigned, the dielectric-based elements can offer minor loss and linear reflection phase with a 2π reflection coverage under different values of h as shown in Fig. A2 (a). The electric-field edge illumination of the simulation model shown in Fig. 4 at 26GHz is plotted in Fig. A2(b), where an around -7dB illumination taper can be observed. For the offset illumination case, a better aperture efficiency is usually obtained when the feeding beam is directed to a point deviation from the aperture center as explained in [28].

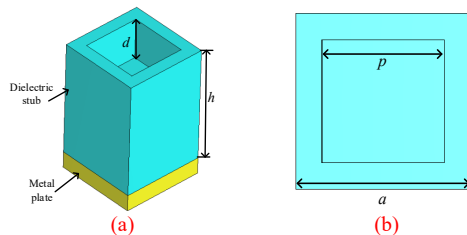


Fig. A1. The geometry of the dielectric-based element. (a). Perspective view. (b). Front view. ($a = 5\text{mm}$, $p = 3.5\text{mm}$, $d = 2.5\text{mm}$)

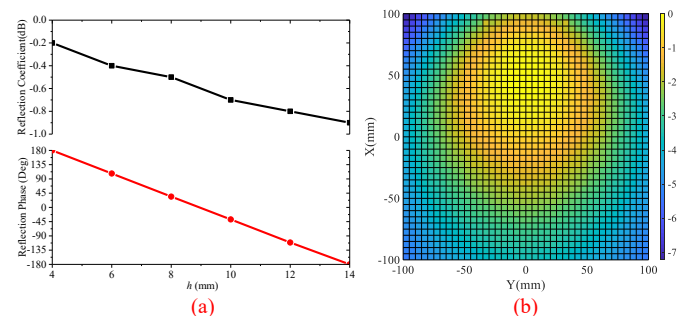


Fig. A2. (a). The reflection phase and coefficient of the dielectric-based element with different values of h . (b). The edge illumination of the simulation model shown in Fig. 4 at 26GHz.

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